

REC'D 3 0 MAR 2004

#### Intyg Certificate

Härmed intygas att bifogade kopior överensstämmer med de handlingar som ursprungligen ingivits till Patent- och registreringsverket i nedannämnda ansökan.

This is to certify that the annexed is a true copy of the documents as originally filed with the Patent- and Registration Office in connection with the following patent application.

REGISTAFA SESSI SESSI (71) (71)

Sökande Telefonaktiebolaget L M Ericsson (publ), Stockholm Applicant (s) SE

- (21) Patentansökningsnummer 0301005-5 Patent application number
- (86) Ingivningsdatum
  Date of filing

2003-04-03

Stockholm, 2004-03-23

För Patent- och registreringsverket For the Patent- and Registration Office

OVWWW.

Marita Öun

Avgift Fee

## PRIORITY DOCUMENT

SUBMITTED OR TRANSMITTED IN COMPLIANCE WITH RULE 17.1(a) OR (b)

+46 8 7641514

Ink. t. Patent- och reg.verke 2003 -04- **0** 3

1

Huvudfaxen Kassan

### Method and system of jitter compensation

#### TECHNICAL FIELD OF THE INVENTION

5

30

The present invention relates to sigma-delta modulators,  $\Sigma\Delta$  modulators, and phase locked loops. Especially, it relates to jitter compensation in  $\Sigma\Delta$ -controlled fractional-N frequency synthesizers.

#### BACKGROUND AND DESCRIPTION OF RELATED ART

Many communications systems require stable and low noise frequency for communication. Exemplary such systems are 10 GSM, DCS 1800 and Bluetooth. Stable frequencies, flexible to various reference oscillator frequencies, can achieved by a fractional-N synthesizer. A fract.ional-N synthesizer generates frequencies between two respective nominal frequencies determined from two rationals times a 15 reference frequency. Generally the rationals are achieved by a frequency dividing circuit altering between two inte-By altering between the rationals according ger divisors. to a specified pattern a desired frequency can be achieved for a range of reference oscillators. A problem of alter-20 ing between frequencies (division ratios) is that phase noise is introduced. The synthesized frequency will comprise a range of frequency components of the output signal being higher or lower than the desired frequency. ΣΔ-controlled fractional synthesizer according to prior art 25 is shown in figure 1.

U.K. Patent Application GB2097206 illustrates a phase locked loop type frequency synthesizer including a dual switched frequency divider. A compensation signal is generated and adaptively adjusted to reduce phase jitter. The phase jitter is due to the output pulses of the variable

10

→→ PRV HUVUDFAX Ink. t. Patent- och reg.verket

2003 -04- 0 3

2

Huvudfaxen Kassan

divider not being regularly spaced. In one embodiment the irregularities are suppressed before the signal is applied to the input of the phase comparator.

- U.S. Patent US5834987 describes frequency synthesizer systems and methods including a programmable frequency divider. The divider is controlled to divide frequency of a VCO output signal by a first or a second integral ratio. A ΣΔ modulator is responsive to a modulation input to produce the divider control input. A ripple compensation signal is provided to phase detector output.
- U.S. Patent US4179670 discloses a fractional division ratio synthesizer with jitter compensation. Jitter compensation is inserted at output of phase comparator. The compensated signal is passed through a loop filter to a voltage-controlled oscillator. A nominal division ratio of M is increased by 1 for a fraction of a number of periods at a reference frequency, f<sub>r</sub>. The fraction is a ratio of N/2<sup>n</sup>, where N may be increased by 1 on a cyclic basis using a ΣΔ modulator clocked at f<sub>r</sub>.
- 20 U.S. Patent US4771196 describes an electronically variable active analog delay line utilizing cascaded differential transconductance amplifiers with integrating capacitors.
  - U.S. Patent application US20020008557 presents a digital phase locked loop where the output of a digital controlled oscillator feeds multi-stage tapped delay lines, providing a range of clock signals at different frequencies. A control signal representing timing error in the output signal determines a tap of the tapped delay line for output.
- U.S. Patent US5036294 reveals a switched capacitor phase 30 locked loop.

25

· 5

10

15

+46 8 7641514

2003 -04- 0 3

•

Huvudiaxen Kassan

None of the cited documents above discloses a method and system for frequency synthesis providing jitter compensation prior to phase detection or posterior to oscillator signal generation of a phased locked loop, wherein jitter compensation is introduced by means of a variable delay line.

## SUMMARY OF THE INVENTION

For phase locked loop frequency synthesizers, fast switching between different frequencies (as e.g. in a High-Rate extension to Bluetooth) requires large loop bandwidths. Prior art phase locked loops with large loop bandwidth generally has too much out-of-band noise in many applications. A substantial part of prior art noise originates from the frequency divider when switching between different divisors.

Consequently, it is an object of this invention to provide a method and system of jitter compensation, reducing outof-band noise stemming from frequency division circuits.

Further, it is an object to reduce such noise/jitter, prior to the jitter being further affected by phase detector non-linearities.

It is also an object to accomplish jitter compensation by means of variable delay circuitry and delay control circuitry.

25 Another object is to accomplish the delay control by means of a  $\Sigma\Delta$  modulator.

Finally, it is also an object to realize the variable delay circuitry by means of a controllable tapped delay line.

These objects are met by the invention controlling a multistage tapped delay line.

Preferred embodiments of the invention, by way of examples, are described with reference to the accompanying drawings below.

## BRIEF DESCRIPTION OF THE DRAWINGS

Figure 1 illustrates a  $\Sigma\Delta$ -controlled synthesizer according to prior art.

Figure 2 shows a first embodiment of compensation of  $\Sigma\Lambda$  10 modulator induced jitter according to the invention.

Figure 3 shows the first embodiment of compensation of  $\Sigma\Lambda$  modulator induced jitter according to the invention with a digital variable delay.

Figure 4 shows a generalized first embodiment of compensation of  $\Sigma\Lambda$  modulator induced jitter according to the invention.

Figure 5 shows a second embodiment of compensation of  $\Sigma\Delta$  modulator induced jitter according to the invention.

Figure 6 shows a third embodiment of compensation of  $\Sigma\Lambda$  20 modulator induced jitter according to the invention.

Figure 7 shows an embodiment of delay control according to the invention.

Figure 8 shows an embodiment of variable delay realized by a tapped delay line according to the invention.

25 Figure 9 shows a first canonical form of variable delay realized by a tapped delay line comprising D flip-flops according to the invention.

Huvudiuxen Kassan

Figure 10 shows a second canonical form of variable delay realized by a tapped delay line comprising D flip-flops according to the invention.

Figure 11 illustrates a 50% duty cycle clock frequency sig-5 nal according to the invention.

## DESCRIPTION OF PREFERRED EMBODIMENTS

With reference to figure 1, a  $\Sigma\Delta$ -controlled synthesizer architecture comprises a phase-frequency detector «PFD», a low-pass loop filter «LPF», a voltage controlled oscillator «VCO» and a frequency divider «Divide by N or N+1». The frequency divider «Divide by N or N+1» is controlled by a  $\Sigma\Delta$  modulator « $\Sigma\Delta$  modulator» clocked at frequency  $f_{\rm ref}$  with a fractional setting input «fraction». The reference clock signal « $f_{\rm ref}$ » of frequency  $f_{\rm ref}$  is input to the phase-frequency detector to be compared with the frequency-divided output signal « $f_{\rm out}$ » of the voltage-controlled oscillator «VCO». By modulating the frequency division factor via the  $\Sigma\Delta$  modulator «Div ctrl» an average frequency division factor via factor,  $N_a$ , is obtained

20

25

30

15

10

## $N \leq N_a \leq N+1$ .

The power spectral density of the frequency division factor is small for low frequencies and increases to a maximum for frequencies around  $f_{\rm ref}/2$ , with a  $\Sigma\Lambda$  modulator clocked at  $f_{\rm ref}$ . High frequency components are suppressed by the low-pass loop filter «LPF». However, out-of-band noise level may still be too high for many applications. This is particularly a problem for larger loop-bandwidths. Larger loop-bandwidths are e.g. necessary when fast switching between different frequencies is required, as is the case in e.g. high-rate extensions to Bluetooth.

Physician Kossan

6

Some prior art solutions compensate this noise by adding a compensation current at the input of the loop filter. This solution, however, encounters at least two disadvantages:

- Due to non-linearities in the phase detector the phase noise will be frequency translated from higher frequencies to lower (baseband). Once in baseband it will be difficult, if not impossible, to compensate for the phase noise.
- For digital implementations of the ΣΔ convertable.
   ers (which are more common than analog ΣΔ converters), an analog digital-analog, D/A, converter is required to convert the compensation signal to an analog current. Requiring one or more D/A converters makes manufacturing processing more complicated.

The invention solves these problems by phase-compensating a signal prior to the signal being input to the phase-frequency detector «PFD».

Figure 2 shows a first embodiment of compensation of ΣΔ 20 modulator induced jitter according to the invention.

A variable delay element «Var delay» delays the input signal to the phase detector «PFD» in accordance with a control signal from a control element «Delay calc», calculating the required jitter compensation. Preferably, also the control element is clocked at frequency  $f_{\rm ref}$ . The required jitter compensation is determined from signals available from the  $\Sigma\Lambda$  modulator. The delay-control signal «DCS» is input to the variable delay element «Var delay».

The variable delay «Var delay» controls the momentary phase of the signal. Preferably, the controlled quantity is the momentary zero-crossing of the signal fed to the input of

25

15

20

25

Huvudfaxen Kassan

7

The variable delay the phase-frequency detector «PFD». then controls the zero crossing instances.

With no compensation, as in figure 1, and assuming a locked loop, the time between two zero-crossings, Td, of the signal  $\ll s_{fb} \gg$  fed back to detector  $\ll PFD \gg$  at time  $nT_{ref}$ , where n is an integer and  $T_{ref}=1/f_{ref}$  could be expressed as

$$T_{\rm d}(mT_{\rm ref}) = N_{\rm a}T_{\rm out} + q(mT_{\rm ref}) T_{\rm out}$$
 ,

where  $T_{\text{out}}=1/f_{\text{out}}$  and  $q(nT_{\text{ref}})$  is the period jitter.

The accumulated phase jitter at period n, assuming system startup at period 0, then is 10

$$\Delta\phi(mT_{\rm ref}) = 2\pi \ f_{\rm ref} \ T_{\rm out} \sum_{k=0}^{m} q(kT_{\rm ref}) \ .$$

The variable delay may be realized entirely digitally as particularly illustrated in figure 3, also illustrating clocking «Clk2» of the digital delay «Dig Delay». bly, the digital delay is clocked by the output frequency signal «fout». Both positive and negative flanks of the output frequency signal «fout» can be used to achieve a stepsize as small as 0.5 Tout, for a 50% duty cycle output frequency signal. As in figure 2, the control element «Delay calc» and the  $\Sigma\Delta$  modulator « $\Sigma\Delta$  modulator» are preferably clocked «Clk1» by the reference frequency clock signal  $\ll f_{ref} \gg .$ 

In a generalized embodiment an average division factor,  $N_a$ , is obtained by weighting. Figure 4 illustrates a generalized first embodiment where a range of frequency division factors,  $N_i \in \{..., N-1, N+1, N+2, ...\}$ , are averaged by weighting

BRICSSON ERA ZP

→→→ PRV HUVUDFAX

+46 8 7641514

Ink. t. Patent- och reg.verket

2003 -04- 0 3 ·

8

Huyudlaxen Kessan

$$N_{\alpha} = \sum_{i} w_{i}N_{i}$$
 ,

where wi are weights, such that

$$\sum_{i} w_{i} = 1.$$

Similar generalization also applies to the second and third embodiments as would be obvious to the reader.

Figure 5 shows a second embodiment of compensation of  $\Sigma\Delta$ modulator induced jitter according to the invention. In figure 5 the jitter is compensated prior to the dividing element «Divide by N or N+1». As compared to the preferred embodiment of figure 2 the frequency of the signal input to the variable delay «Var/dig delay» is much higher. ther, the divisor of the division element needs to be compensated for. The delay calculator and the  $\Sigma\Delta$  modulator are clocked «Clk1» by the reference frequency «fref». variable delay «Var/dig delay» could be analog or digital. Preferred embodiments of analog and digital delays according to the invention are illustrated in figures 8-10. the case of digital delay, the delay elements of variable delay «Var/dig delay» are preferably clocked by a clock signal «Clk2» identical to the input signal «fout». Consequently, the clock signal could be retrieved internally of the variable delay «Var/dig delay» without a particular external clock signal input port. For smallest stepsize, the delay elements of a digital variable delay are preferably triggered by both positive and negative flanks of a 50% duty cycle clock signal. The clock signal «Clk2» is not required for an analog variable delay «Var/dig delay».

Figure 6 shows a third embodiment of compensation of  $\Sigma\Delta$  modulator induced jitter according to the invention. The

10

15

20

25

ERICSSON ERA ZP ---- INV HOVUD PAX regularly

'03 04/03 TOR 16:38 PAX +46 8 7641514

10

15

25

30

+46 8 7641514

Ink. t. Patent- och reg.verket

2003 -04- 0 3

9

Huyudlaran Kassan

output signal of phase-frequency detector «PFD» depends on the phase difference between its two input signals. difference is the same whether the phase of the first input is advanced or the phase of the second input is lagged. Consequently, the sign of the variable delay of element «Var/dig delay» is reversed as compared to the embodiment of figure 2. As in figure 5 the delay calculator «Delay calc» and the  $\Sigma\Delta$  modulator are clocked «Clk1» by the refer-The variable delay «Var/dig delay» ence frequency «fref». could be analog or digital. For the case of digital delay, the delay elements are clocked by clock signal «Clk2». Preferably, the output frequency signal «fout» is used for clocking the digital variable delay as in the embodiment of figure 3. Both positive and negative flanks of the output frequency signal «fout» can be used to achieve a stepsize as small as 0.5 Tout, for a 50% duty cycle output frequency signal. The clock signal input «Clk2» is not required for an analog variable delay «Var/dig delay».

The embodiments of figures 2-6 can be combined. The inven-20 tion covers, e.g., embodiments with more than one variable delay element.

Figure 7 shows an embodiment of delay control according to the invention. An estimate of the accumulated phase-jitter  $\Delta\phi(nT_{\rm ref})$  is obtained by integrating an error signal «E». The error signal is the difference between the input signal «fraction», corresponding to the desired fraction  $N_{\rm A}$ , and the output signal «Div ctrl» controlling the frequency dividing element «Divide by N or N+1». «Div ctrl» is output from a  $\Sigma\Delta$  modulator clocked by clock signal «Clock». Phase is basically integrated frequency and the error signal «E» is integrated and scaled by  $2\pi/N_{\rm a}$  to obtain the estimated phase jitter in «Delay calc». The variable delay and delay

25

30

+46 8 7641514

2003 -04- 0 3

10

Huyudlaxen Keesen

control signal «DCS» corresponds to this estimate for the embodiment of figure 2. Also «Delay calc» is clocked by clock signal «Clock». The delay control signal of the embodiment in figure 5 is  $N_a$  times greater, or alternatively the variable delay is scaled accordingly in delay element «Var/dig delay». The delay control signal of the embodiment in figure 6 has a reversed sign or this sign is included in delay element «Var/dig delay».

Figure 8 shows an embodiment of an analog variable delay realized by a tapped delay line according to the invention. 10 The tapped delay line is composed of a number of cascaded segments, each comprising an amplifier, illustrated as an inverter, with transconductance, Gi, a capacitor with capacitance,  $C_i$ , and a switch  $S_i$ ,  $i \in [0,n]$ , where n is the number of segments of the tapped delay line. The total delay 15 of the tapped delay line equals the sum of delays of segments with closed switches  $S_i$ , where segment i with closed switch contributes with a delay proportional to  $G_i/C_i$ . Various transconductances Gi can be obtained by varying supply voltage or bias current (depending on the transconduc-20 tance circuitry).

A noisy variable delay may itself introduce more phase noise than compensated by the varying delay. For a tapped delay line as illustrated in figure 8, the noise level can be kept at a minimum if powered from a low-noise stabilized supply voltage and by not using more delay than necessary. Deviation from nominal values due to tolerances of manufacturing processes may also call for consideration. For most applications particular low-noise designed inverters are not required. A further advantage of the embodiment of figure 8 in relation to jitter compensation is that a separate multi-bit digital-analog, D/A, converter can be eliminated.

+46 8 7641514

Hypeligeen Kessan

Given equal transconductances, Gi, for all inverters, the capacitors may represent binary values, i.e.  $C_i=2^iC_0$ , i>0. The switches  $S_i$ ,  $i \ge 0$ , can then have their binary correspondences (1 for closed switch and 0 for an open switch) in a 5 binary delay control signal. At least this is the case for a desired level of precision as, as explained above, the delay line generated noise increases with number of seg-However, also other alternatives of representing the delay are covered by this invention as well.

- 10 A great advantage of the embodiment of the variable delay as illustrated in figure 8 is that the capacitors can be implemented by gate-bulk capacitances of CMOS transistors. Thereby the variable delay can be implemented in a well known digital CMOS manufacturing process.
- The tapped delay line may also be fully digital as illus-15 trated in figures 9 and 10. The figures show embodiments of variable delay realized by a tapped delay line comprising D flip-flops  $\mbox{$<$D_0$}\mbox{$>$}$ ,  $\mbox{$<$D_1$}\mbox{$>$}$ ,  $\mbox{$<$D_2$}\mbox{$>$}$ , ...,  $\mbox{$<$D_n$}\mbox{$>$}$ . The D flipflop  $\mbox{$<$D_0$}\mbox{$>$}$  is optional. Each D flip-flop  $\mbox{$<$D_0$}\mbox{$>$}$  ...,  $\mbox{$<$D_n$}\mbox{$>$}$ clocked by a clock signal «Clock». If the flip-flops are 20 flank-triggered on only one flank (positive or negative) each flip-flop represents a delay stepsize of Tclock, where T<sub>clock</sub> is the time-period of the clock signal «Clock». Preferably, the flip-flops are triggered on both positive and negative flanks of a 50% duty cycle clock signal, illus-25 trated in figure 11, the delay stepsize is reduced to In figure 11, a bias level illustrates that the clock frequency signal can be NRZ (no return to zero) or RZ (return to zero). In figures 9 and 10, the switches  $S_i$ , i =0,1,2, ... n, are controlled by the delay control signal. 30 In both figures 9 and 10 only one of the switches «So»,

 $\ll S_1 \gg$ , ...,  $\ll S_n \gg$  are connected at the same time.

7003 -04- 0 3

Figure 9 shows a first canonical form and figure 10 a second canonical form of a fully digital tapped delay line.

Some exemplary features and characteristics of the invention are listed below.

- 5 1. A method of jitter compensation of a phase locked loop frequency synthesizer by means of a variable delay, the method characterized in that the jitter is compensated prior to a signal being subject to jitter is passed through a non-linearity, the jitter compensating variable delay being realized by means of a tapped delay line.
- The method according to characteristic 1 c h a r a c t e r i z e d i n that each of a plurality of integer divisors are selected according to a fractional pattern,
   representing fractional weighting of the integer divisors, generated by a ΣΔ modulator from a fractional setting input.
- The method according to characteristic 1 or 2 c h a r a c t e r i z e d i n that a fraction of a first
   and a second integer is determined by a binary fractional pattern, for selecting the first or the second integer, generated by a ΣΔ modulator from a fractional setting input.
- 4. The method according to characteristic 2 or 3  $\Sigma$ 0 matrix and the control signals derived from the  $\Sigma$ 1 modulator.
- 5. The method according to characteristic 4 c h a r a c t e r i z e d i n that a control signal for control30 ling the tapped delay line is determined by integrating and

scaling an error signal being the difference between a signal representing the fraction and a signal carrying the fractional pattern.

- 6. The method according to any of characteristics 1-5 characteristics 1-5 characteristics 1 in that the tapped delay line comprises a plurality of capacitors with capacitances proportional to successive powers of 2.
- 7. The method according to characteristic 5 or 6 characteristic 5
- 8. The method according to any of characteristics 1-5
  15 characteristics 1-5
  characteristics 1-5
  comprises a plurality of serially connected delay elements.
- 9. The method according to characteristic 5 or 8 characteristic 5
  - 10. The method according to characteristic 9 c h a r a c t e r i z e d i n that the control signal carries a bit representation for connecting or disconnecting a delay element output to the output of the tapped delay line.
  - 11. The method according to characteristic 9 characterized in that the control signal carries a bit representation for connecting or disconnecting a delay element input to the input of the tapped delay line.

THE LETTING CONTROL OF THE LETTING

- 12. The method according to any of characteristics 1-11 c h a r a c t e r i z e d i n that the non-linearity is included in or is a phase or frequency detector.
- 13. The method according to any of characteristics 1-12
  5 characterized in that the output signal of the tapped delay line is input to the phase or frequency detector.
  - 14. The method according to any of characteristics 1-13 characteristics din that at least one of
- 10 a reference frequency signal,
  - a frequency divided output signal of a voltage controlled oscillator,
  - a frequency divided output signal of the frequency synthesizer.
- is input to and delayed by the tapped delay line.
  - 15. The method according to any of characteristics 1-12 c h a r a c t e r i z e d i n that the output signal of the tapped delay line is input to frequency dividing circuitry.
- 20 16. The method according to any of characteristics 1-12 and 15 characterized in that at least one of
  - an output signal of a voltage controlled oscillator, and
- 25 an output signal of the frequency synthesizer is input to and delayed by the tapped delay line.
  - 17. A phase locked loop frequency synthesizer with jitter compensation by means of a variable delay, the frequency

+46 8 7641514

2003 -04- D 3

15

Heynellower Kriesem

synthesizer characterized by a tapped delay line compensating the jitter prior to a signal being subject to jitter is passed through a non-linearity.

- The frequency synthesizer according to characteristic 17 characterized by a  $\Sigma\Delta$  modulator for gen-5 erating or a storing element for pre-generated storing of a fractional pattern representing fractional weighting of a plurality of integer divisors, the fractional pattern selecting one integer divisor, out of the plurality of integer divisors, at a time to be active. 10
- The frequency synthesizer according to characteristic 19. characterized by a  $\Sigma\Delta$  modulator for generating or a storing element for pre-generated storing of a binary fractional pattern for determining a fraction of a first and a second integer, the binary fractional 15 pattern selecting the first or the second integer, the binary fractional pattern being generated from or restored from a fractional setting input.
- The frequency synthesizer according to characteristic 20. characterized by control means for con-20 trolling the tapped delay line by means of one or more control signals derived from the  $\Sigma\Delta$  modulator.
- The frequency synthesizer according to characteristic 21. characterized by an integrator integrating and scaling an error signal being the difference be-25 tween a signal representing the fraction and a signal carrying the binary fractional pattern, the integrator output signal being a signal for controlling the tapped delay line.
- The frequency synthesizer according to any of charac-30 teristics 17-21 characterized in that the

30

2003 -04- D a

16

Huyudleynn Kassan

tapped delay line comprises a plurality of capacitors with capacitances proportional to successive powers of 2.

- 23. The frequency synthesizer according to characteristic 21 or 22 c h a r a c t e r i z e d b y switches for connecting or disconnecting capacitors of the tapped delay line, wherein respective capacitances corresponding to bit positions of a binary representation of a binary number are connected or disconnected, the binary number being carried by the one or more control signals.
- 10 24. The frequency synthesizer according to any of characteristics 17-21 c h a r a c t e r i z e d b y the tapped delay line comprising a plurality of serially connected delay elements.
- 25. The frequency synthesizer according to characteristic
  15 21 or 24 c h a r a c t e r i z e d b y one or more
  switches for connecting or disconnecting one or more delay
  elements to the input or output of the tapped delay line
  according to a bit representation, the bit representation
  being carried by a control signal.
- 20 26. The frequency synthesizer according to characteristic 25 characteristic et a racterized by the one or more switches each connecting or disconnecting a delay element output to the output of the tapped delay line.
- 27. The frequency synthesizer according to characteristic 25 25 characteristic ed by the one or more switches each connecting or disconnecting a delay element input to the input of the tapped delay line.
  - 28. The frequency synthesizer according to any of characteristics 17-27 characterized in that the non-linearity is included in or is a phase or frequency detector.

**:**::

+46 8 7641514

2003 -04- 0 3

17

Hrantlason Russan

- 29. The frequency synthesizer according to any of characteristics 17-28 characterized in that the output signal of the tapped delay line is input to the phase or frequency detector.
- 5 30. The frequency synthesizer according to any of characteristics 17-29 characterized in that at least one of
  - a reference frequency signal,
- a frequency divided output signal of a voltage controlled oscillator,
  - a frequency divided output signal of the frequency synthesizer,

is input to and delayed by the tapped delay line.

- 31. The frequency synthesizer according to any of charactoristics 17-28 characterized in that the output signal of the tapped delay line is input to frequency dividing circuitry.
- 32. The frequency synthesizer according to any of characteristics 17-28 and 31 characterized in that at least one of
  - an output signal of a voltage controlled oscillator, and
  - an output signal of the frequency synthesizer

is input to and delayed by the tapped delay line.

25 33. A radio communications system characterized by means for carrying out the method in any of characteristics 1-16. +46 8 7641514

7(33 -04- 0 3

18

Hevedlasen Kassan

34. A radio communications system characterized by one or more frequency synthesizers according to any of characteristics 17-32.

The invention is not intended to be limited only to the embodiments described in detail above. Changes and modifications may be made without departing from the invention. It covers all modifications within the scope of the following claims.

→→→ PRV HUVUDFAX ERICSSON ERA ZP

'03 04/03 TOR 16:41 FAX +46 8 7641514

25

+46 8 7641514

Ink. t. Patent- och mg.verket

19

2003 -04- 0 3

Huyudfaxon Kassan

#### CLAIMS

- A method of jitter compensation of a phase locked loop frequency synthesizer by means of a variable delay, the method characterized in that the jitter is compensated prior to a signal being subject to jitter is passed through a non-linearity, the jitter compensating variable delay being realized by means of a tapped delay line.
- The method according to claim 1 character-2. ized in that each of a plurality of integer divisors 10 are selected according to a fractional pattern, representing fractional weighting of the integer divisors, generated by a  $\Sigma\Lambda$  modulator from a fractional setting input.
- The method according to claim 1 or 2 characterized in that a fraction of a first and a second integer is determined by a binary fractional pattern, for 15 selecting the first or the second integer, generated by a  $\Sigma\Delta$  modulator from a fractional setting input.
- The method according to claim 2 or 3 characterized in that the tapped delay line :s controlled by means of control signals derived from the  $\Sigma\Delta$ 20 modulator.
  - The method according to claim 4 characterin that a control signal for controlling the tapped delay line is determined by integrating and scaling an error signal being the difference between a signal representing the fraction and a signal carrying the fractional pattern.
    - The method according to any of claims 1-5 characterized in that the tapped delay line com-

prises a plurality of capacitors with capacitances proportional to successive powers of 2.

- The method according to claim 5 or 6 characin that the control signal carries a biterized nary number whose bit representation connects or disconnects capacitors of the tapped delay line with respective capacitances corresponding to bit positions of the binary representation.
- The method according to any of claims 1-5 c h a r -8. in that the tapped delay line comacterized 10 prises a plurality of serially connected delay elements.
  - The method according to claim 5 or 8 charac terized in that the control signal carries a representation for connecting or disconnecting a delay element of the tapped delay line to either the input or output of the tapped delay line.
- The method according to claim 9 characteri z e d i n that the control signal carries a bit representation for connecting or disconnecting a delay element output to the output of the tapped delay line. 20
  - The method according to claim 9 characterin that the control signal carries a bit representation for connecting or disconnecting a delay element input to the input of the tapped delay line.
- The method according to any of claims 1-11 char-25 acterized in that the non-linearity is included in or is a phase or frequency detector.
  - The method according to any of claims 1-12 c. h a r -13. in that the output signal of the acterized

tapped delay line is input to the phase or frequency detector.

- 14. The method according to any of claims 1-13 characterized in that at least one of
- 5 a reference frequency signal,
  - a frequency divided output signal of a voltage controlled oscillator,
  - a frequency divided output signal of the frequency synthesizer,
- 10 is input to and delayed by the tapped delay line.

+46 8 7641514 .

- 15. The method according to any of claims 1-12 c h a r a c t e r i z e d i n that the output signal of the tapped delay line is input to frequency dividing circuitry.
- 16. The method according to any of claims 1-12 and 15 characterized in that at least one of
  - an output signal of a voltage controlled oscillator, and
  - an output signal of the frequency synthesizer is input to and delayed by the tapped delay line.
- 20 17. A phase locked loop frequency synthesizer with jitter compensation by means of a variable delay, the frequency synthesizer c h a r a c t e r i z e d b y a tapped delay line compensating the jitter prior to a signal being subject to jitter is passed through a non-linearity.
- 25 18. The frequency synthesizer according to claim 17 c h a r a c t e r i z e d b y a  $\Sigma\Delta$  modulator for generating or a storing element for pre-generated storing of a fractional pattern representing fractional weighting of a

25

Ink. t. Pateni- och rog, verket

22

Huyudfaxen Kassan

2003 -04- 0 3

plurality of integer divisors, the fractional pattern selecting one integer divisor, out of the plurality of integer divisors, at a time to be active.

- 19. The frequency synthesizer according to claim 17 or 18

  5 characterized by a ΣΔ modulator for generating or a storing element for pre-generated storing of a binary fractional pattern for determining a fraction of a first and a second integer, the binary fractional pattern selecting the first or the second integer, the binary fractional pattern tional pattern being generated from or restored from a fractional setting input.
  - 20. The frequency synthesizer according to claim 19 c h a r a c t e r i z e d b y control means for controlling the tapped delay line by means of one or more control signals derived from the  $\Sigma\Delta$  modulator.
- 21. The frequency synthesizer according to claim 20 c h a r a c t e r i z e d b y an integrator integrating and scaling an error signal being the difference between a signal representing the fraction and a signal carrying the binary fractional pattern, the integrator output signal being a signal for controlling the tapped delay line.
  - 22. The frequency synthesizer according to claim 21 c h a r a c t e r i z e d b y switches for connecting or disconnecting capacitors of the tapped delay line, wherein respective capacitances corresponding to bit positions of a binary representation of a binary number are connected or disconnected, the binary number being carried by the one or more control signals.
- 23. The frequency synthesizer according to claim 21
  30 characterized by one or more switches for connecting or disconnecting one or more delay elements to

70-3-04-03

23

Flory Resen Kreson

the input or output of the tapped delay line according to a bit representation, the bit representation being carried by a control signal.

- 24. A radio communications system character-5 ized by means for carrying out the method in any of claims 1-16.
  - 25. A radio communications system characterized by one or more frequency synthesizers according to any of claims 17-23.

'03 04/03 TOR 16:43 FAX +46 8 7641514

Ś

+46 8 7641514

Ink. L. Palent- och rug.verket

2003 -04- 0 3

24

Huvudfaxon Kessan

## ABSTRACT

The present invention relates to sigma-delta modulators,  $\Sigma\Delta$  modulators, and phase locked loops. Especially, it relates to jitter compensation in  $\Sigma\Delta$ -controlled fractional-N frequency synthesizers. Jitter compensation is introduced by means of a variable delay line.

Figure for publication with abstract: figure 6.

+46 8 7641514

Ink. t. Pateni- och rcg.verket

2003 -04- 0 3

Huvudlaxen Kassan

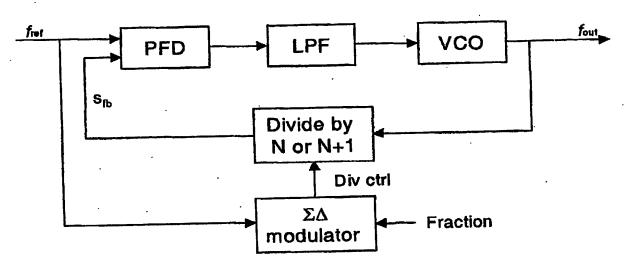


Fig. 1

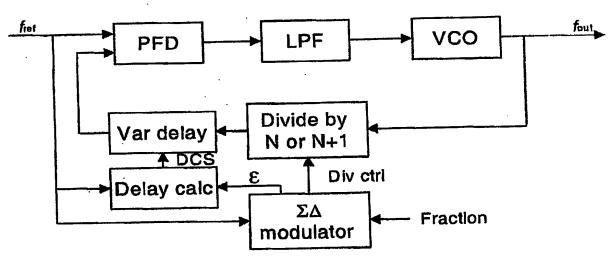


Fig. 2

2/6

Ink. t. Patent- ection g. verket 2003 = 0.4 - 0.3

Hovodistion Kessen

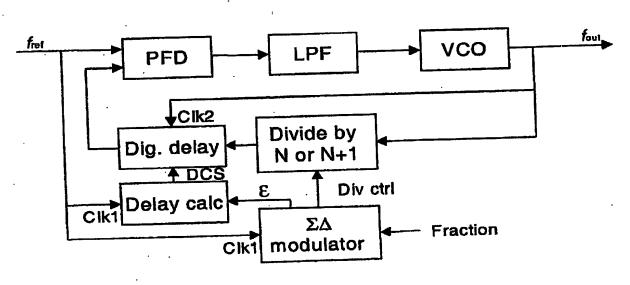


Fig. 3

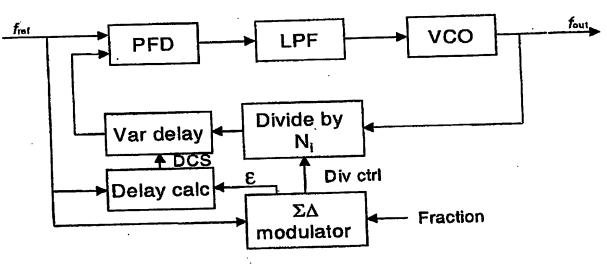


Fig. 4

+46 8 7641514

Ink. I. Paisti- och agverket

2003 -04- 0 3

Huvudlasen Kassan

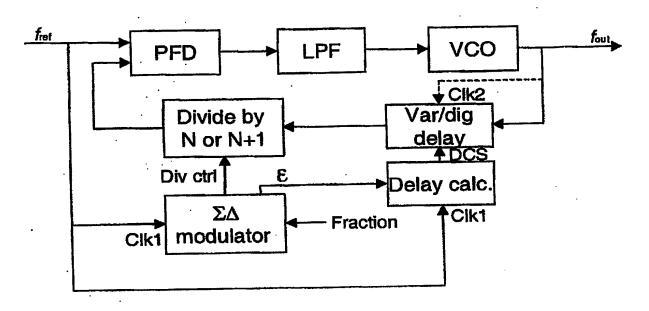


Fig. 5

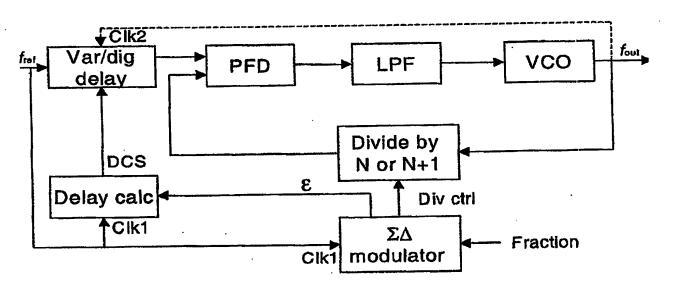
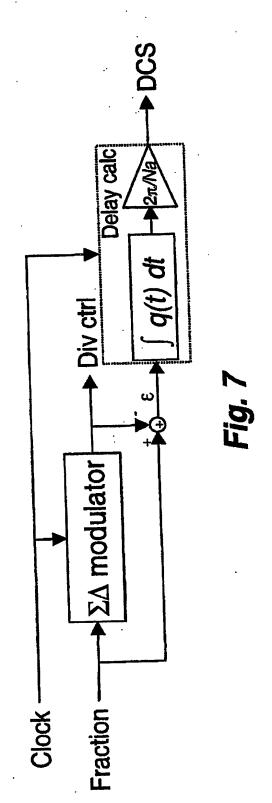


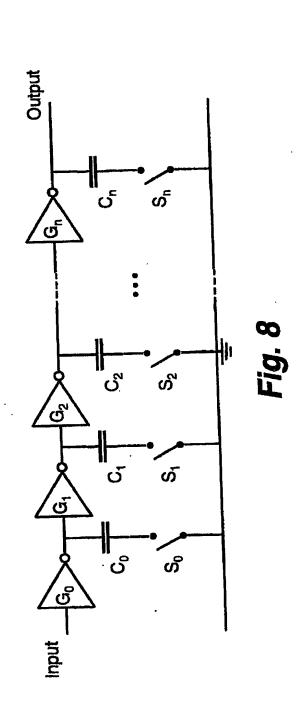
Fig. 6

Ink. t. Paleni- odni giverket

2003 -04- 0 3

Hisvudferna Kassan

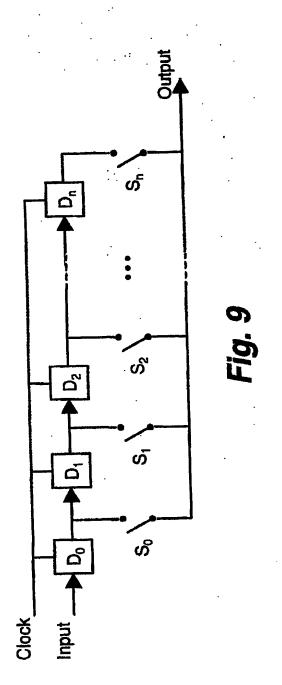


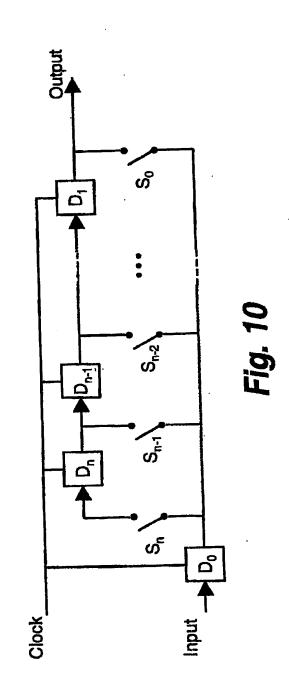


Ink. t. Patent- och mg.verket

2003 -04- 0 3

Huvudiaven Kassan





'03 04/03 TOR 16:44 FAX +48 8 7641514

ERICSSON ERA ZP

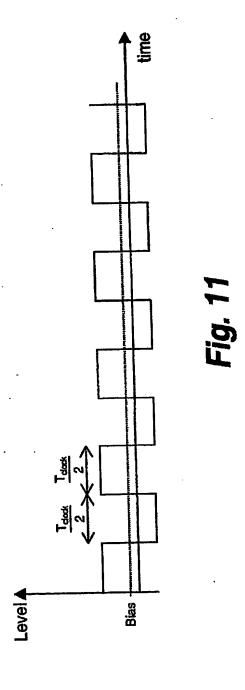
→→→ PRV HUVUDFAX

.+46 8 7641514

6/6

Ink t. Palsni- och magverket 2003 -04- 0 3

Huyudiczen Kutunn



# This Page is inserted by IFW Indexing and Scanning Operations and is not part of the Official Record

## **BEST AVAILABLE IMAGES**

Defective images within this document are accurate representations of the original documents submitted by the applicant.

Defects in the images include but are not limited to the items checked:

| X | BLACK BORDERS   |
|---|---|
| × | IMAGE CUT OFF AT TOP, BOTTOM OR SIDES                 |
| X | FADED TEXT OR DRAWING                                 |
| · | BLURED OR ILLEGIBLE TEXT OR DRAWING                   |
|   | SKEWED/SLANTED IMAGES                                 |
| × | COLORED OR BLACK AND WHITE PHOTOGRAPHS                |
| ۵ | GRAY SCALE DOCUMENTS                                  |
|   | LINES OR MARKS ON ORIGINAL DOCUMENT                   |
|   | REPERENCE(S) OR EXHIBIT(S) SUBMITTED ARE POOR QUALITY |
|   | OTHER:  |

IMAGES ARE BEST AVAILABLE COPY.
As rescanning documents will not correct images problems checked, please do not report the problems to the IFW Image Problem Mailbox